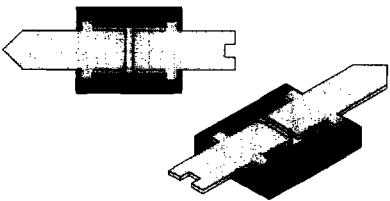


Planar and Mesa Beam Lead PIN Diodes

DSG64XX, DSM63XX Series

Features

- Low Capacitance
- Low Resistance
- Fast Switching
- Oxide–Nitride Passivated
- Stronger, Full Frame Design
- High Voltage



Maximum Ratings

Operating Temperature:	–65 to + 150 °C
Storage Temperature:	–65 to + 200 °C
Power Dissipation (Derate Linearly to Zero @ 175°C):	250 mW
Typical Lead Strength:	8 Grams Pull

Description

Alpha’s Silicon Planar and Mesa Beam Lead PIN diodes are surrounded by a glass frame for superior strength and electrical performance that surpasses the standard beam lead PINs. They are designed for low resistance, low capacitance and fast switching time. The oxide–nitride passivation layers provide reliable operation and stable junction parameters that provide complete sealing of the junction permitting

use in assemblies with some degree of moisture sealing. A layer of glass provides increased mechanical strength.

Alpha’s beam lead PIN diodes are ideal for microstrip or stripline circuits and for circuits requiring high isolation from a series mounted diode such as broad band multi–throw switches, phase shifters, limiters, attenuators and modulators.

Electrical Specifications

Low Capacitance Planar Beam Lead Diodes

Part Number	Breakdown Voltage @ 10 μ A (Volts)		Capacitance Total @ 50 Volts, 1 MHz (pF)		Series Resistance @ 20 mA 100 MHz (Ohms)		Minority Carrier Lifetime IF=10mA, IR=6mA (ns)	Reverse Recovery Time IF=20 mA, VR=10V, 90% Recovery (ns)		Outline Drawing Number
	min	typ	typ	max	typ	max	typ	typ	max	
DSG6405	100	125	0.017	0.02	4.5	6.0	85	20	35	389–004

Performance Data for DSG6405

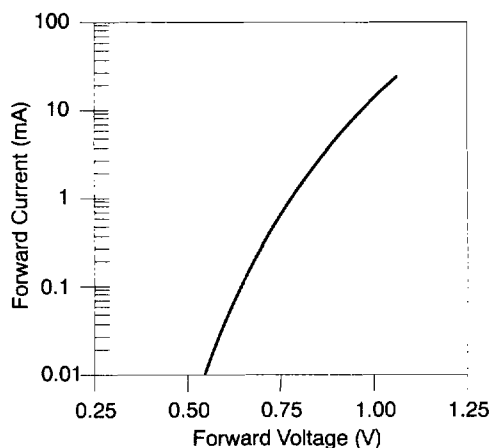


Figure 1. Typical Forward Characteristics

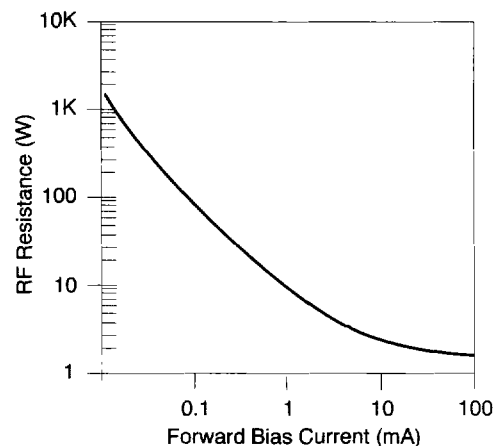


Figure 3. Typical RF Resistance vs. Forward Bias Current

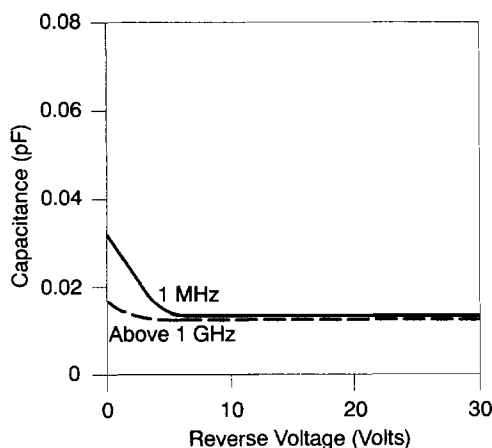


Figure 2. Typical Capacitance vs. Reverse Bias Voltage

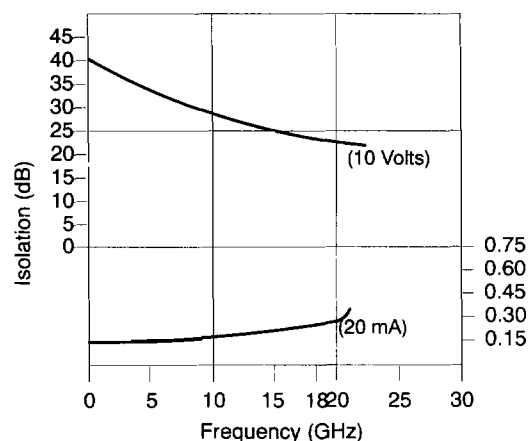


Figure 4. Typical Insertion Loss and Isolation Characteristics

Electrical Specifications

Planar Beam Lead Diodes

Part Number	Voltage Breakdown @ 10 mA (min)	Series Resistance (Ohms) (From Insertion Loss @ 3 GHz, 50 mA) ¹ (max)	Junction Capacitance C _J (pF) (max)	RF Switching Time T _S (ns) ²	Minority Carrier Lifetime Typ. (ns)	Outline Drawing Number
DSG6470-06	200	5.5	0.03	25	100	169-001
DSG6470-30	200	4.0	0.02	25	100	169-001
DSG6474-06	100	5.5	0.03	25	100	169-001
DSG6474-30	100	4.0	0.02	25	100	169-001

1. Total capacitance calculated from isolation at 9 GHz zero bias. Series resistance and capacitance are measured at microwave frequencies on a sample basis from each lot. All diodes are characterized for capacitance at -50 Volts, 1 MHz, and series resistance at 1 KHz, 50 mA, measurements which correlate well with microwave measurements.

2. T_S measured from RF transition, 90% to 10%, in series configuration.

Performance Data for DSG6470/74 Series

Figure 5, which is a typical application of a beam lead PIN diode, is a single pole double-throw 1–18 GHz switch these diodes are mounted on Alumina, Duroid, or Teflon fiberglass 50 ohm microstrip circuits. Typical bonding methods include thermal compression bonding, parallel gap welding, and soldering.

SPDT isolation curves are shown in Figure 6 and insertion loss in Figures 7 and 8. With proper transitions and bias circuits, VSWR is better than 2.0 to 1 through 18 GHz.

Switching Considerations

The typical minority carrier lifetime of the DSG6470 and DSG6474 diodes is 100 ns. With suitable drivers, the individual diodes can be switched from high impedance (off) to low Rs (on) in about 10 ns.

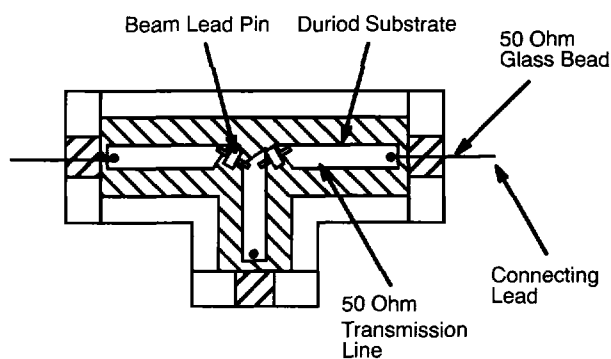


Figure 5. Typical SPDT Circuit Arrangement

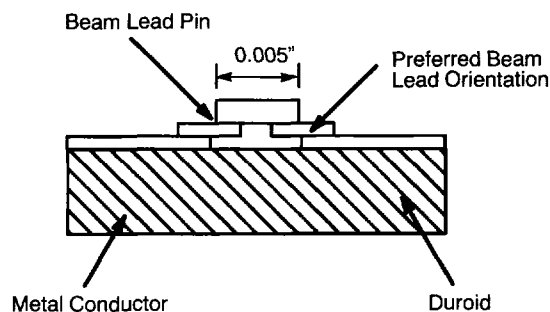


Figure 6. Typical Beam Lead Mounting

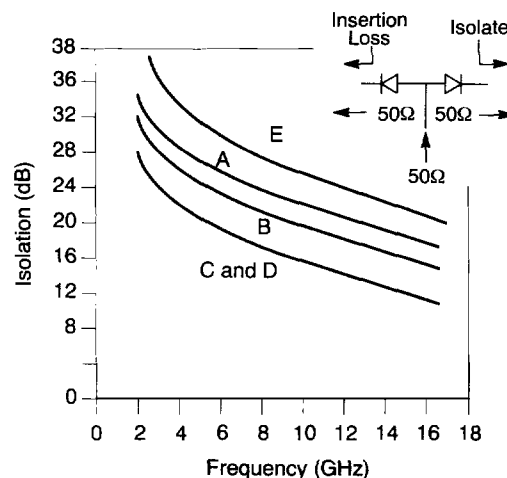


Figure 7. Isolation vs. Frequency, SPDT DSG6470, DSG6474 Series

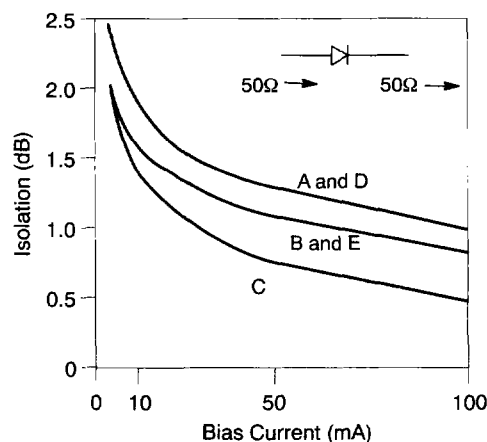


Figure 8. Diode Insertion Loss vs. Bias SPST, 18 GHz DSG6470, DSG6474 Series

Power Handling for DGS64XX

Beam lead diodes are not suitable for high power operation because of high internal thermal impedance of about 600°C/Watt.

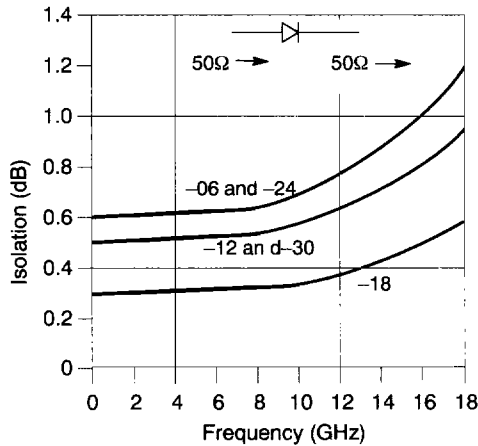


Figure 9. Diode Insertion Loss vs. Frequency
SPST, 50 mA Bias DSG6470, DSG6474 Series

With maximum CW power dissipation of 250 mW, the DSG6470 and DSG6474 diodes are normally rated at 2 Watt CW with linear derating between 25°C and 150°C. Figure 10 presents data on CW power handling as a function of bias and frequency.

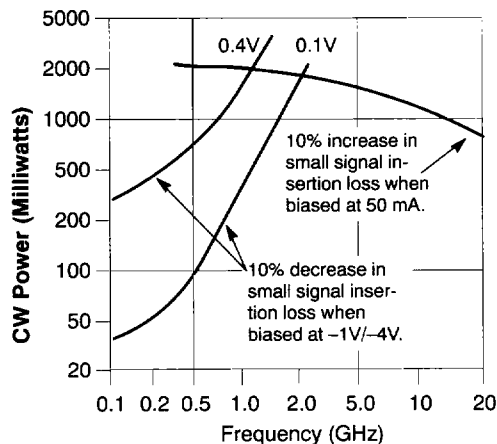


Figure 10. Typical Series Switch Behavior at
Room Temperature and Biased at 50ma/1V/
4V DSG6470, DSG6474 Series

For pulsed operation, the total RF plus bias voltage must not exceed the rated breakdown. Alpha has made high power tests at 1 GHz with 1μs pulses, 0.001 duty, with 200V diodes. With 50 mA forward bias, there is no increase in insertion loss over the 0 dBm level with a peak power input of 50 watts. In the open state, reverse bias voltage is required to keep the diode from “rectifying,” with resultant decrease in isolation and possible failure. Figure 11 shows allowed peak power versus reverse bias at 1 GHz.

At this frequency, the required reverse voltage is almost equal to the peak RF voltage; at high frequency, the bias can be reduced somewhat. Experimentation is necessary.

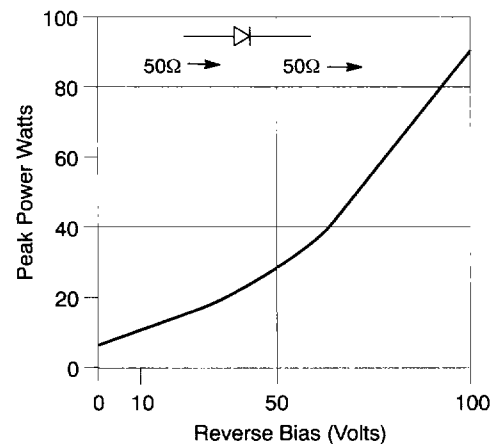


Figure 11. Peak Power Handling, SPST, 1 GHz
DSG6470, DSG6474 Series

Mesa Beam Lead Diode Specifications

Part Number	Voltage Breakdown @ IR < 10 mA (Volts) max	Capacitance Total 50 Volts, 1MHz (pF) max	Series Resistance (Ohms)		CLT IF=10mA, IR=6mA (ns) typ	Outline Drawing Number
			50 mA, 100 MHz max	10 mA, 100 MHz typ		
Fast Beam Lead Pin Diodes						
DSM6380-06	100	0.03	3.5	4.0	40	389-003
DSM6380-12	100	0.04	3.0	3.5	50	389-003
DSM6380-30	100	0.025	4.0	4.5	40	389-003
DSM6381-06	150	0.03	4.0	4.5	60	389-003
DSM6381-12	150	0.04	3.5	4.0	80	389-003
DSM6381-30	150	0.025	4.5	5.0	50	389-003
Ultra-Fast Beam Lead PIN Diodes						
DSM6340	80	0.025	3.0	3.8	30	389-003
DSM6341	80	0.035	2.5	3.5	30	389-003
Low-Loss Ultra-Fast Beam Lead PIN Diodes						
DSM6361	60	0.025 ¹	3.5 ²	—	25	389-003
DSM6362	60	0.045 ¹	3.0 ²	—	30	389-003
1. Capacitance Total @ 10 Volts, 1 MHz, pF, Max.						
2. Series Resistance @ 10 mA, Ohms, Max., 100 MHz.						

Part Number	Voltage Breakdown @ 10μA, Reverse Current		Series Resistance @ 50 MHz, 50 mA		Capacitance Total @ -10V, 1 MHz		Lifetime (ns)	Switching Time (ns)	Video Recovery Time (ns) ²	Outline Drawing Number
	min	typ	typ	max	typ	max	typ ¹	typ ²		
Ultra Low Resistance High-Speed Beam Lead PIN Diodes										
DSM6355	50	80	1.5	2.0	0.07	0.08	40	10	3	389-003
DSM6356	30	50	1.2	1.5	0.12	0.15	30	5	2	389-003
1. IF=10mA, I=6mA, recovery to 3 mA.										
2. Video recovery time at 2 GHz from IF=10mA to VR=10V, from 100% to 10% in series configuration. Video reverse recovery time from IF=10mA to IR=2mA, with VR=10mV.										

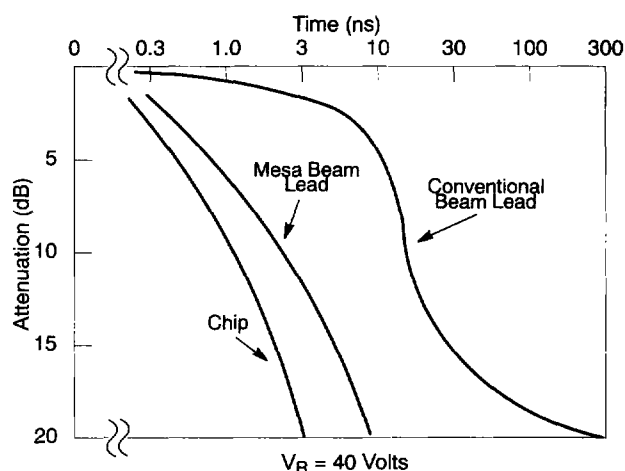


Figure 12. Switching Time Data

Performance Data for DSG6380 and 81

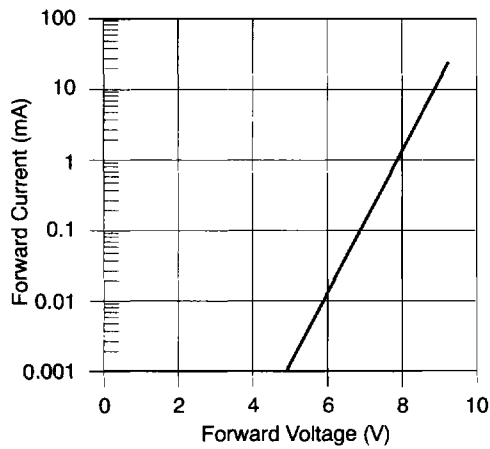


Figure 13. Typical Forward Characteristics of the DSM6380 Series

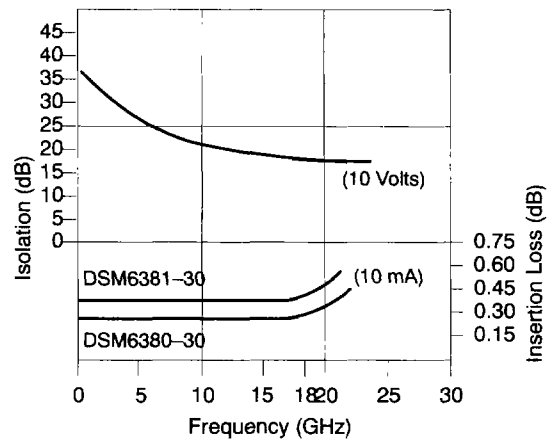


Figure 15. Typical Isolation and Insertion Loss Characteristics of the DSM6380/6381-30

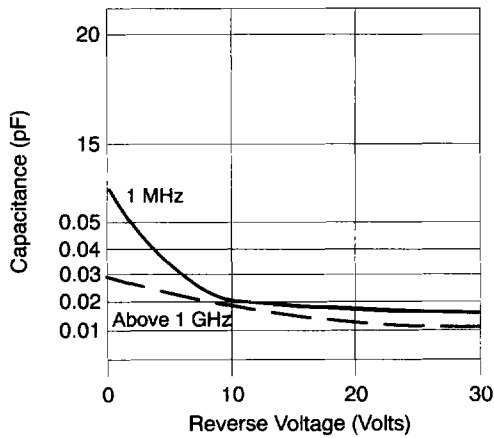


Figure 14. Typical Capacitance vs. Reverse Voltage for DSM6380-30

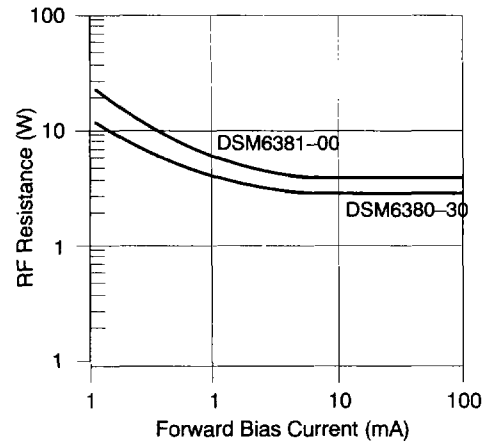


Figure 16. Typical RF Resistance vs. Forward Bias Current for DSM6380/81-30

Performance Data for DSG6340/41 and 61

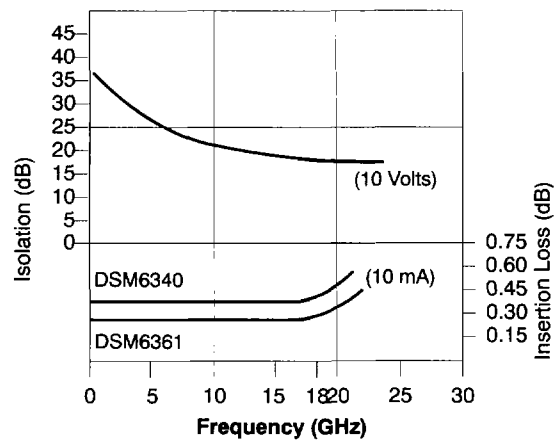


Figure 17. Typical Isolation and Insertion Loss Characteristics of the DSM6340 and DSM6361

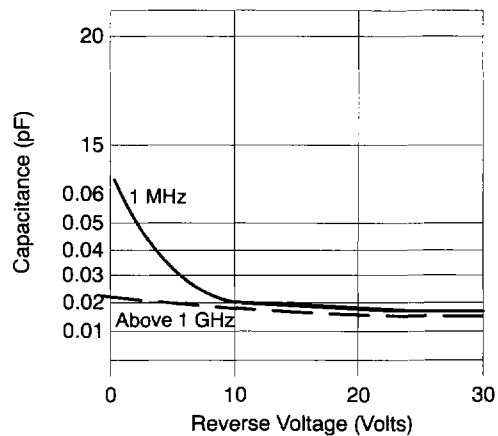


Figure 19. Typical Capacitance vs. Reverse Voltage for DSM6340

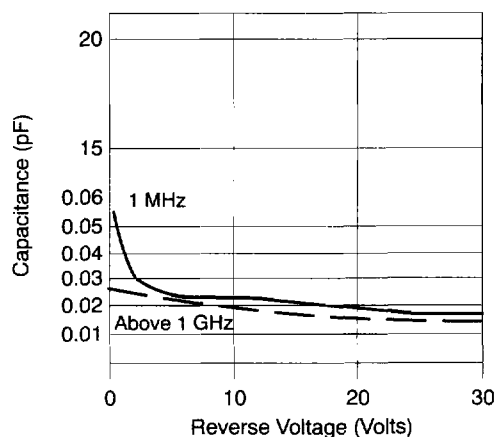


Figure 18. Typical Capacitance vs. Reverse Voltage for DSM6361

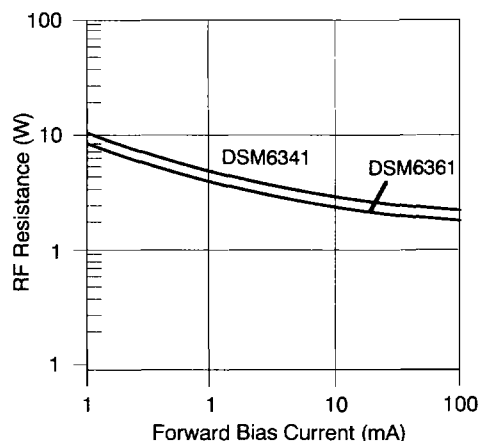


Figure 20. Typical RF Resistance vs. Forward Bias Current for DSM6361, and DSM6341

Performance Data for DSM6355 and DSM6356

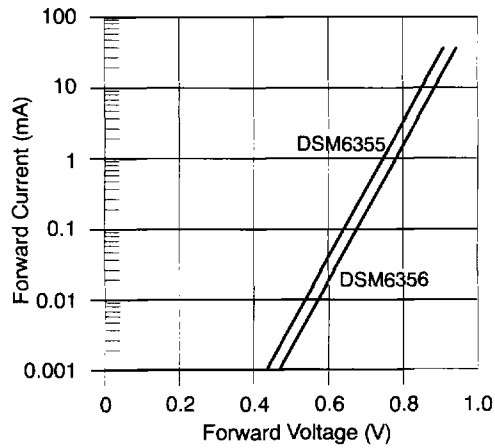


Figure 21. Typical Forward Characteristics

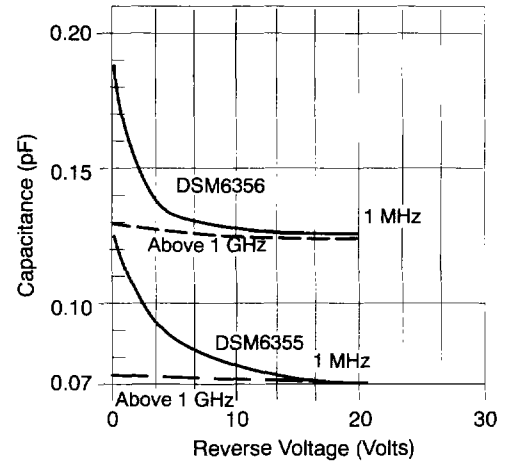


Figure 23. Typical Capacitance vs. Reverse Voltage

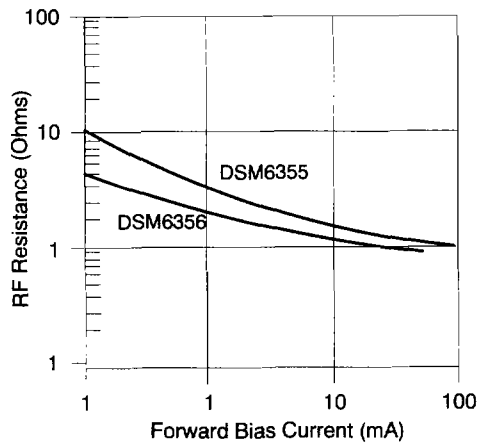


Figure 22. Typical RF Resistance vs. Forward Bias Current

Outline Drawing 389-004

